

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-			
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NON-PATENT DOCUMENTS

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U	Hall Effect Sensor: Retrieved from " http://hades.mech.northwestern.edu/wiki/index.php/Hall_Effect_Sensor "
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